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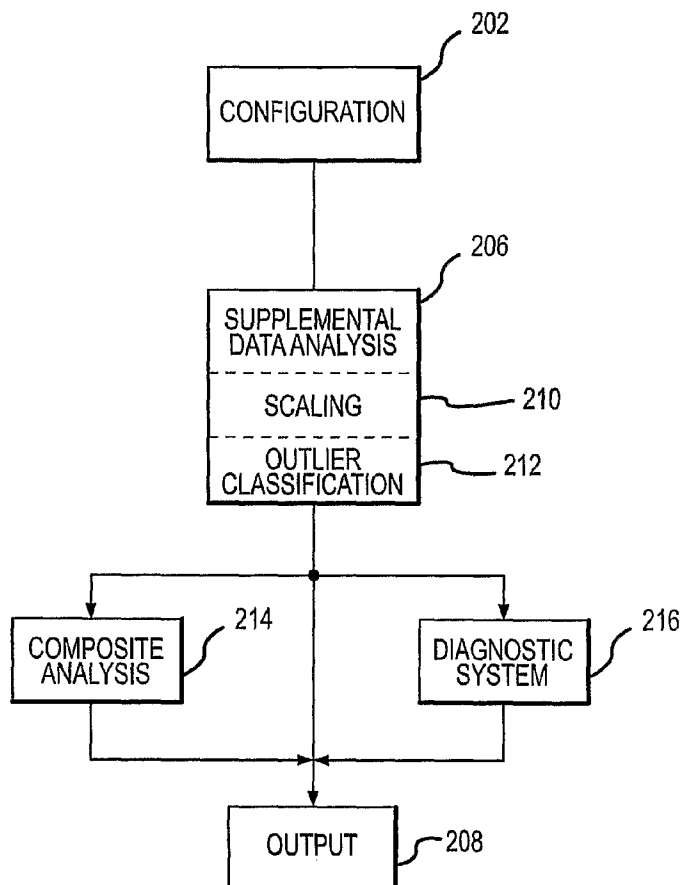
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[Continued on next page]

(54) Title: METHODS AND APPARATUS FOR DATA ANALYSIS



(57) Abstract: A method and apparatus for data analysis according to various aspects of the present invention is configured to automatically identify a characteristic of a fabrication process for components based on test data for the components.

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